

N- Channel 100V (D-S) MOSFET

GENERAL DESCRIPTION

The ME35N10 is the N-Channel logic enhancement mode power field effect transistors are produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application.

FEATURES

- $R_{DS(ON)} \leq 22m\Omega @ V_{GS}=10V$
- $R_{DS(ON)} \leq 26m\Omega @ V_{GS}=4.5V$
- Super high density cell design for extremely low $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability

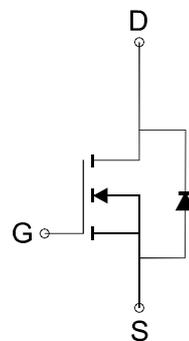
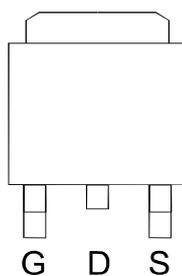
APPLICATIONS

- DC/DC Converter
- Load Switch
- LCD/ LED Display inverter

PIN CONFIGURATION

(TO-252-3L)

Top View



N-Channel MOSFET

Ordering Information: ME35N10 (Pb-free)

ME35N10-G (Green product-Halogen free)

Absolute Maximum Ratings (Tc=25°C Unless Otherwise Noted)

Parameter	Symbol	Maximum Ratings	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current*	I_D	$T_c=25^\circ C$	28.1
		$T_c=70^\circ C$	22.5
Pulsed Drain Current	I_{DM}	112	A
Maximum Power Dissipation*	P_D	$T_c=25^\circ C$	27.8
		$T_c=70^\circ C$	17.8
Operating Junction Temperature	T_J	-55 to 150	°C
Thermal Resistance-Junction to Case*	$R_{\theta JC}$	4.5	°C/W

*The device mounted on 1in² FR4 board with 2 oz copper



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Electrical Characteristics (T_c = 25°C Unless Otherwise Specified)

Symbol	Parameter	Limit	Min	Typ	Max	Unit
STATIC						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250 μA	100			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250 μA	1		3	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =80V, V _{GS} =0V			1	μA
R _{DS(ON)}	Drain-Source On-State Resistance ^a	V _{GS} =10V, I _D = 20A		17	22	mΩ
		V _{GS} =4.5V, I _D = 16A		20	26	
V _{SD}	Diode Forward Voltage	I _S =12A, V _{GS} =0V			1.3	V
DYNAMIC						
Q _g	Total Gate Charge	V _{DS} =80V, V _{GS} =10V, I _D =35A		94.7		nC
Q _g	Total Gate Charge			54.2		
Q _{gs}	Gate-Source Charge	V _{DS} =80V, V _{GS} =5V, I _D =35A		16.5		
Q _{gd}	Gate-Drain Charge			20.8		
C _{iss}	Input capacitance	V _{DS} =15V, V _{GS} =0V, F=1MHz		4400		pF
C _{oss}	Output Capacitance			286		
C _{rss}	Reverse Transfer Capacitance			233		
t _{d(on)}	Turn-On Delay Time	V _{DS} =50V, R _L =1.5Ω V _{GEN} =10V, R _G =4.7Ω		30.3		ns
t _r	Turn-On Rise Time			166		
t _{d(off)}	Turn-Off Delay Time			92.4		
t _f	Turn-Off Fall Time			186		

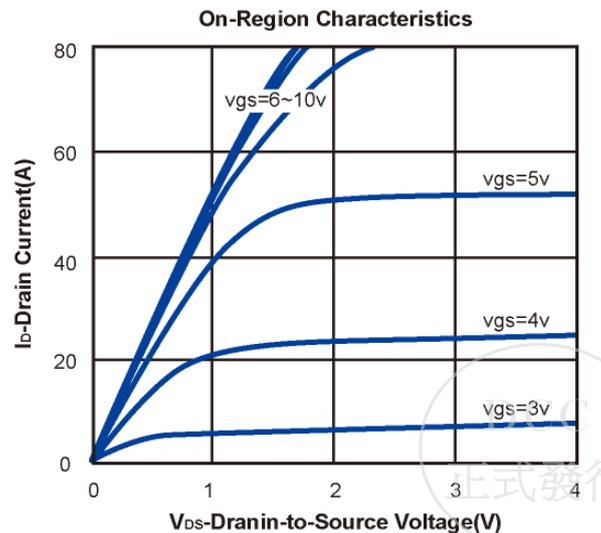
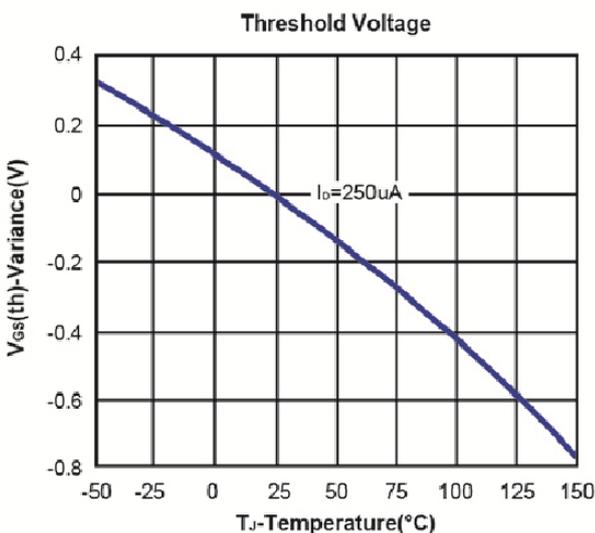
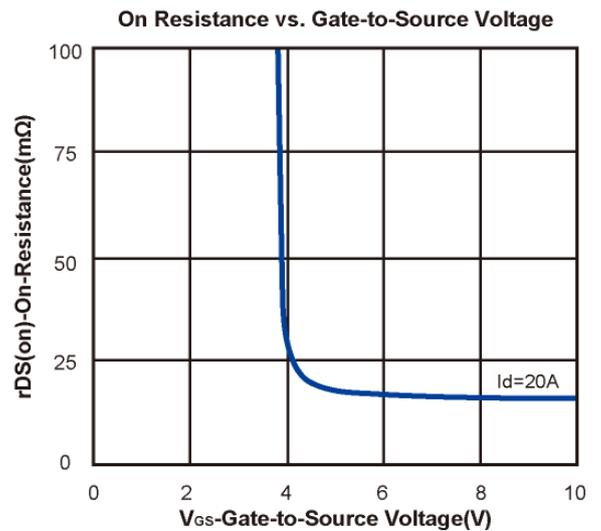
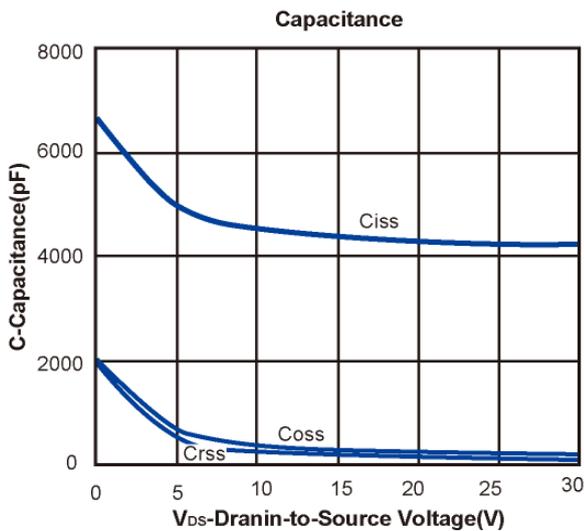
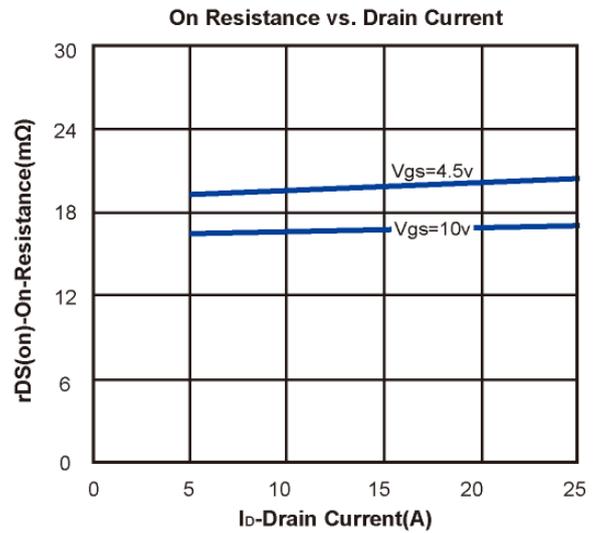
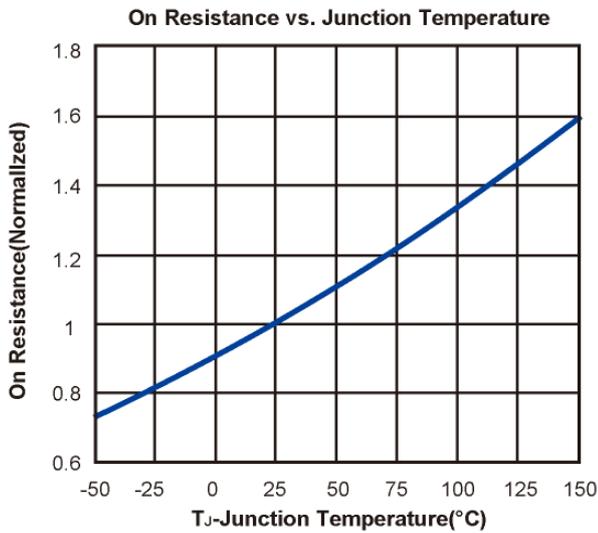
Notes: a. Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%, Guaranteed by design, not subject to production testing.

b. Matsuki Electric/ Force mos reserves the right to improve product design, functions and reliability without notice.

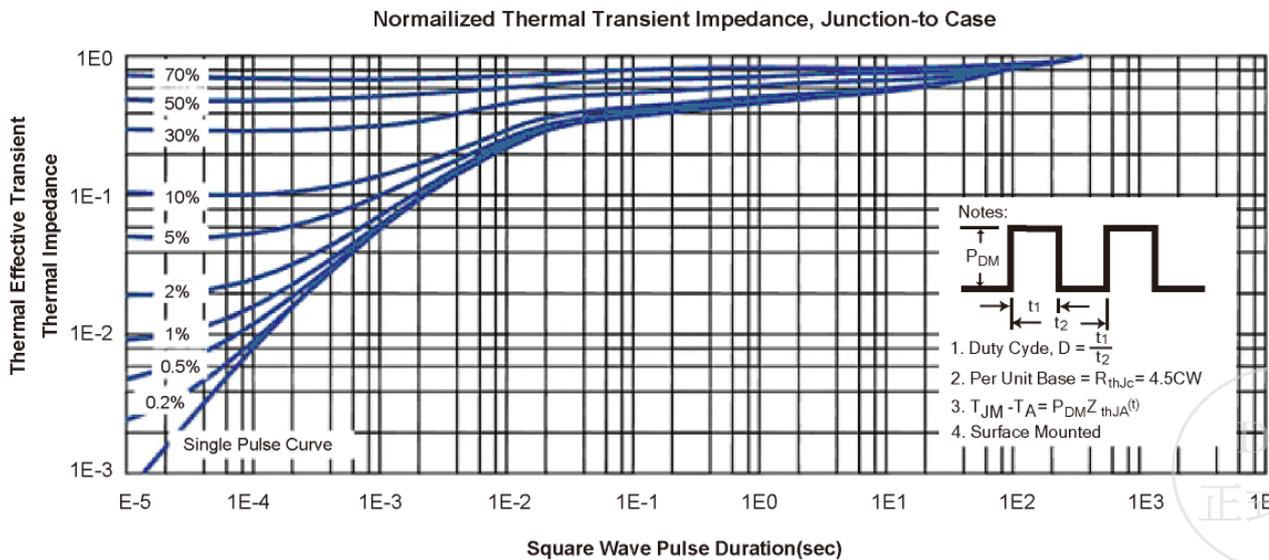
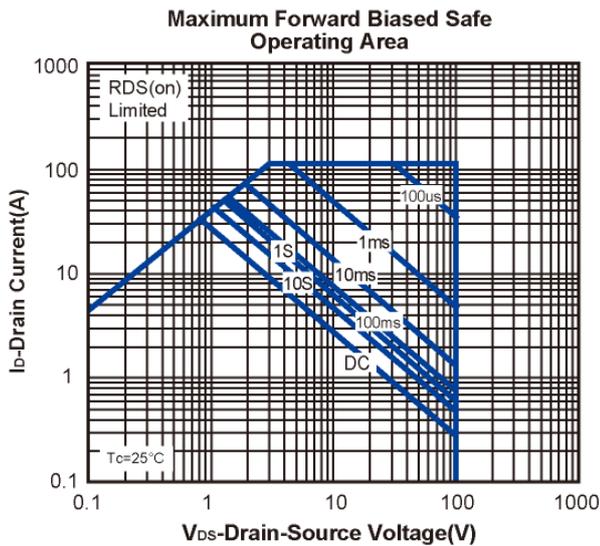
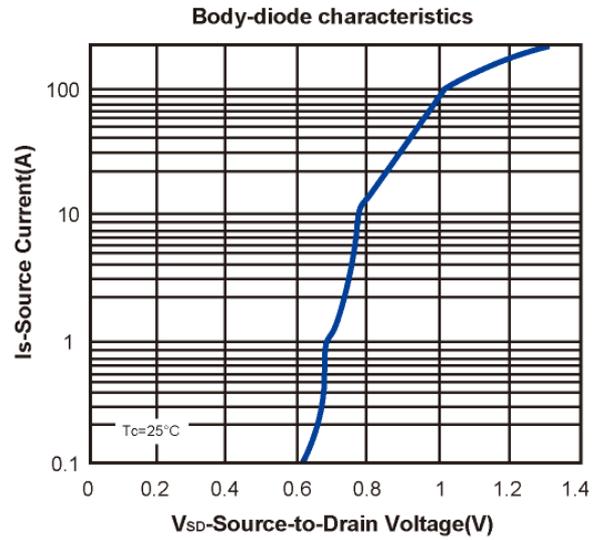
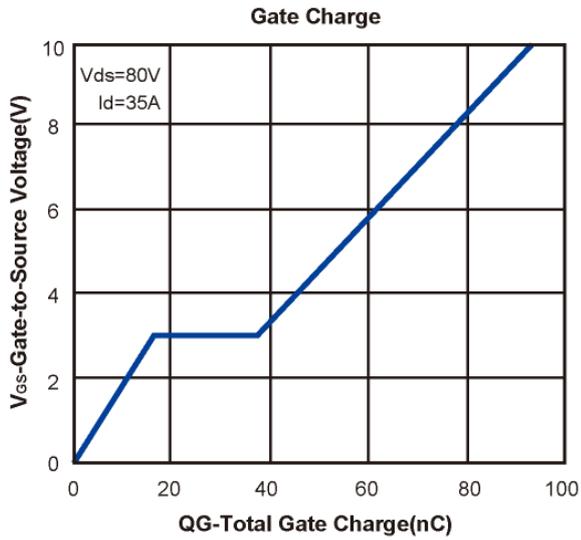


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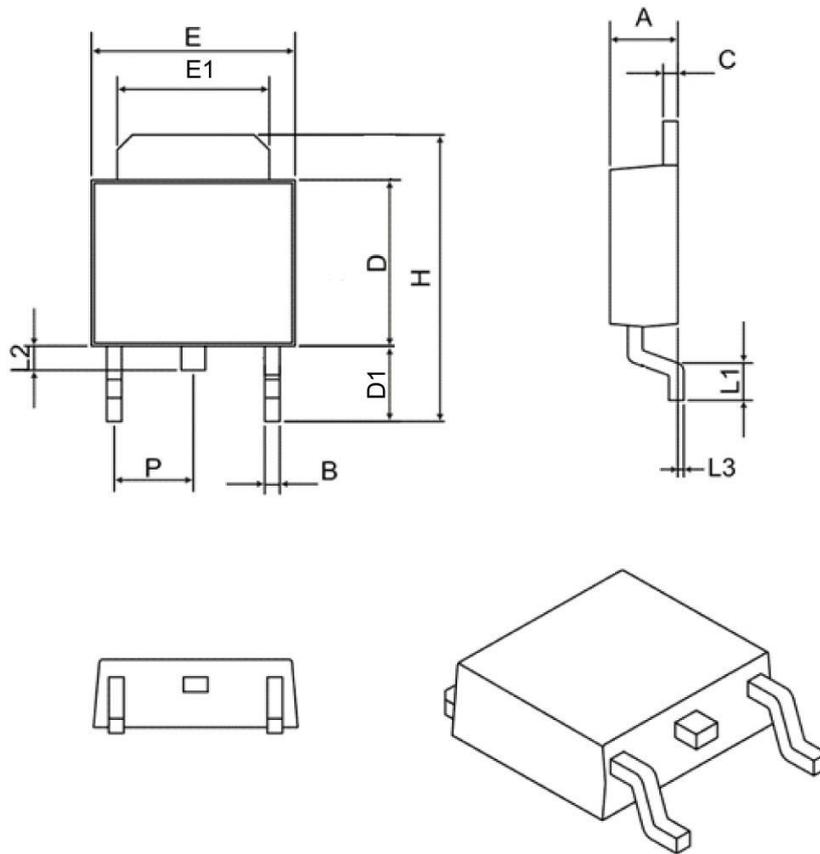
Typical Characteristics (T_J =25°C Noted)



N-Channel 100V (D-S) MOSFET
Typical Characteristics (T_J = 25°C Noted)



TO252-3L Package Outline



SYMBOL	MIN	MAX
A	2.10	2.50
B	0.40	0.90
C	0.40	0.90
D	5.30	6.30
D1	2.20	2.90
E	6.30	6.75
E1	4.80	5.50
L1	0.90	1.80
L2	0.50	1.10
L3	0.00	0.20
H	8.90	10.40
P	2.30 BSC	

